Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/666,200	CHOI, HUN	
Examiner	Art Unit	
Mark J. Beauchaine	3653	

SEARCHED					
Class	Subclass	Date	Examiner		
453	3-5,9,12, 13,58	8/11/2006	МЈВ		
194	334,215-				
	217,350	8/11/2006	МЈВ		
312	330.1,331				
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	350	8/14/2006	МЈВ		
446	8,10	8/15/2006	мјв		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
	F				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST 2.0.1 - USPAT, USPGPUB, USOCR, JPO, EPO	8/11/2006	MJB		